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Irish Standard I.S. EN 61710:2013

Power law model - Goodness-of-fit tests and estimation methods (IEC 61710:2013 (EQV))

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Power law model -Goodness-of-fit tests and estimation methods (IEC 61710:2013)

Modèle de loi en puissance -Essais d'adéquation et méthodes d'estimation des paramètres (CEI 61710:2013) Potenzgesetz-Modell -Anpassungstests und Schätzverfahren (IEC 61710:2013)

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EN 61710:2013

I.S. EN 61710:2013 - 2 -

Foreword

The text of document 56/1500/FDIS, future edition 2 of IEC 61710, prepared by IEC/TC 56 "Dependability" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61710:2013.

The following dates are fixed:

•	latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2014-03-26
•	latest date by which the national standards conflicting with the	(dow)	2016-06-26

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 61703	NOTE	Harmonised as EN 61703.
IEC 61164:2004	NOTE	Harmonised as EN 61164:2004 (not modified).

I.S. EN 61710:2013 - 3 -

EN 61710:2013

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

Publication	Year	Title	<u>EN/HD</u>	Year
IEC 60050-191	1990	International Electrotechnical Vocabulary (IEV) - Chapter 191: Dependability and quality of service	-	-

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CONTENTS

- 2 -

FO	REWC	RD		5
INT	RODL	JCTION		7
1	Scope			
2	Norm	ative re	ferences	8
3	Term	s and de	efinitions	8
4	Symb	ols and	abbreviations	8
5	Powe	r law m	odel	9
6			nents	
-	6.1	•	и	
	•••	6.1.1	Case 1 – Time data for every relevant failure for one or more copies from the same population	
		6.1.2	Case 1a) – One repairable item	
		6.1.3	Case 1b) – Multiple items of the same kind of repairable item observed for the same length of time	
		6.1.4	Case 1c) – Multiple repairable items of the same kind observed for different lengths of time	11
	6.2		 Time data for groups of relevant failures for one or more repairable rom the same population 	12
	6.3		 Time data for every relevant failure for more than one repairable om different populations 	12
7	Statis	tical est	timation and test procedures	13
	7.1	Overvie	ew	13
	7.2	Point e	stimation	13
		7.2.1	Case 1a) and 1b) – Time data for every relevant failure	
		7.2.2	Case 1c) – Time data for every relevant failure	
		7.2.3	Case 2 – Time data for groups of relevant failures	
	7.3		ess-of-fit tests	
		7.3.1	Case 1 – Time data for every relevant failure	
	7 4	7.3.2	Case 2 – Time data for groups of relevant failures	
	7.4		ence intervals for the shape parameter Case 1 – Time data for every relevant failure	
		7.4.1	Case 2 – Time data for groups of relevant failures	
	7.5		ence intervals for the failure intensity	
	1.0	7.5.1	Case 1 – Time data for every relevant failure	
		7.5.2	Case 2 – Time data for groups of relevant failures	
	7.6		ion intervals for the length of time to future failures of a single item	
	-	7.6.1	Prediction interval for length of time to next failure for case 1 – Time data for every relevant failure	
		7.6.2	Prediction interval for length of time to <i>R</i> th future failure for case 1 – Time data for every relevant failure	22
	7.7	Test for	r the equality of the shape parameters $\beta_1, \beta_2,, \beta_k$	23
		7.7.1	Case 3 – Time data for every relevant failure for two items from different populations	23
		7.7.2	Case 3 – Time data for every relevant failure for three or more items	
			from different populations	
			tive) The power law model – Background information	
Anr	iex B ((informa	tive) Numerical examples	31

61710 © IEC:2013	- 3 -

Annex C (informative)	Bayesian estimation for the power law model	41
Bibliography		56

Figure 1 – One repairable item	10
Figure 2 – Multiple items of the same kind of repairable item observed for same length of time	11
Figure 3 – Multiple repairable items of the same kind observed for different lengths of time	12
Figure B.1 – Accumulated number of failures against accumulated time for software system	32
Figure B.2 – Expected against observed accumulated times to failure for software system	32
Figure B.3 – Accumulated number of failures against accumulated time for five copies of a system	35
Figure B.4 – Accumulated number of failures against accumulated time for an OEM product from vendors A and B	37
Figure B.5 – Accumulated number of failures against time for generators	38
Figure B.6 – Expected against observed accumulated number of failures for generators	
Figure C.1 – Plot of fitted Gamma prior (6,7956, 0,0448)	
for the shape parameter of the power law model	
Figure C.2 – Plot of fitted Gamma prior (17,756 6, 1447,408) for the expected number of failures parameter of the power law model	
Figure C.3 – Subjective distribution of number of failures	51
Figure C.4 – Plot of the posterior probability distribution for the number of future failures, M	54
Figure C.5 – Plot of the posterior cumulative distribution for the number of future failures, <i>M</i>	55
Table 1 – Critical values for Cramer-von-Mises goodness-of-fit test at 10 % level of significance	25
Table 2 – Fractiles of the Chi-square distribution	
Table 3 – Multipliers for two-sided 90 % confidence intervals for intensity function for time terminated data	
Table 4 – Multipliers for two-sided 90 % confidence intervals for intensity function for failure terminated data	28
Table 5 – 0,95 fractiles of the <i>F</i> distribution	29
Table B.1 – All relevant failures and accumulated times for software system	31
Table B.2 – Calculation of expected accumulated times to failure for Figure B.2	33
Table B.3 – Accumulated times for all relevant failures for five copies of a system(labelled A, B, C, D, E)	34
Table B.4 – Combined accumulated times for multiple items of the same kind of a system	34
Table B.5 – Accumulated operating hours to failure for OEM product from vendors A and B	36
Table B.6 – Grouped failure data for generators	38
Table B.7 – Calculation of expected numbers of failures for Figure B.6	40
Table C.1 – Strengths and weakness of classical and Bayesian estimation	42

- 4 -

61710 © IEC:2013

Table C.2 – Grid for eliciting subjective distribution for shape parameter eta	46
Table C.3 – Grid for eliciting subjective distribution for expected number of failures parameter η	46
Table C.4 – Comparison of fitted Gamma and subjective distribution for shape parameter $\boldsymbol{\beta}$	48
Table C.5 – Comparison of fitted Gamma and subjective distribution for expected number of failures by time $T=20000\;h$ parameter η	48
Table C.6 – Times to failure data collected on system test	49
Table C.7 – Summary of estimates of power law model parameters	50
Table C.8 – Time to failure data for operational system	53

61710 © IEC:2013

- 5 -

INTERNATIONAL ELECTROTECHNICAL COMMISSION

POWER LAW MODEL – GOODNESS-OF-FIT TESTS AND ESTIMATION METHODS

FOREWORD

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International Standard IEC 61710 has been prepared by IEC technical committee 56: Dependability.

This second edition cancels and replaces the first edition, published in 2000, and constitutes a technical revision.

The main changes with respect to the previous edition are listed below:

- the inclusion of an additional Annex C on Bayesian estimation for the power law model.

The text of this standard is based on the following documents:

FDIS	Report on voting
56/1500/FDIS	56/1508/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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-7-

INTRODUCTION

This International Standard describes the power law model and gives step-by-step directions for its use. There are various models for describing the reliability of repairable items, the power law model being one of the most widely used. This standard provides procedures to estimate the parameters of the power law model and to test the goodness-of-fit of the power law model to data, to provide confidence intervals for the failure intensity and prediction intervals for the length of time to future failures. An input is required consisting of a data set of times at which relevant failures occurred, or were observed, for a repairable item or a set of copies of the same item, and the time at which observation of the item was terminated, if different from the time of final failure. All output results correspond to the item type under consideration.

Some of the procedures can require computer programs, but these are not unduly complex. This standard presents algorithms from which computer programs should be easy to construct.



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